### **Features**

- Industry-standard Architecture
- Low-cost, Easy-to-use Software Tools
- High-speed, Electrically Erasable Programmable Logic Devices - 5 ns Maximum Pin-to-pin Delay
- CMOS- and TTL-compatible Inputs and Outputs
- Latch Feature Holds Inputs to Previous Logic States
- Pin-controlled Standby Power (10 µA Typical)
- Advanced Flash Technology
  - Reprogrammable
  - 100% Tested
- High-reliability CMOS Process
  - 20-year Data Retention
  - 100 Erase/Write Cycles
  - 2,000V ESD Protection
  - 200 mA Latch-up Immunity
- Dual Inline and Surface Mount Packages in Standard Pinouts
- PCI-compliant
- True Input Transition Detection "Z" and "QZ" Version

## **Pin Configurations**

#### All Pinouts Top View

Pin Name	Function
CLK	Clock
IN	Logic Inputs
I/O	Bi-directional Buffers
GND	Ground
VCC	+5V Supply
PD	Power-down

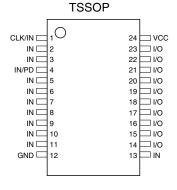
IN/PD [

IN [

IN F

IN [

GND\* F



**DIP/SOIC** 

24 🗆 VCC

23 1/0

22 1/0

21 11/0

20 1/0

19 1/0

18 1/0

17 1/0

16日1/0

15 1/0

14 1/0

13 H IN

CLK/IN 1

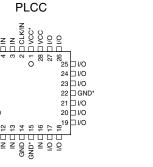
IN/PD 14

IN 2 IN 🗆 3

IN 🗆 9

IN 🗖 10

IN 🗖 11



Note: For all PLCCs (except "-5"), pins 1, 8, 15 and 22 can be left unconnected. However, if they are connected, superior performance will be achieved.

CLK/IN



Highperformance EE PLD

# **ATF22V10C** ATF22V10CQ

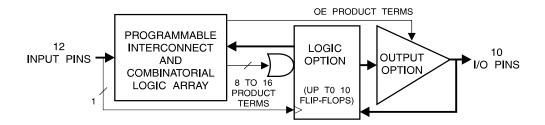
See separate datasheet for ATF22V10CZ and ATF22V10CQZ options.

Rev. 0735P-PLD-01/02





## Logic Diagram



## Description

The ATF22V10C is a high-performance CMOS (electrically erasable) programmable logic device (PLD) that utilizes Atmel's proven electrically erasable Flash memory technology. Speeds down to 5 ns and power dissipation as low as 100  $\mu$ A are offered. All speed ranges are specified over the full 5V ± 10% range for industrial temperature ranges, and 5V ± 5% for commercial temperature ranges.

Several low-power options allow selection of the best solution for various types of power-limited applications. Each of these options significantly reduces total system power and enhances system reliability.

## **Absolute Maximum Ratings\***

*	Temperature under Bias40°C to +85°C	
	Storage Temperature65°C to +150°C	
	Voltage on Any Pin with Respect to Ground2.0V to +7.0V <sup>(1)</sup>	
r	Voltage on Input Pins with Respect to Ground during Programming2.0V to +14.0V <sup>(1)</sup>	
	Programming Voltage with Respect to Ground2.0V to +14.0V <sup>(1)</sup>	

- \*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
- Note: 1. Minimum voltage is -0.6V DC, which may undershoot to -2.0V for pulses of less than 20 ns. Maximum output pin voltage is  $V_{CC}$  + 0.75V DC, which may overshoot to 7.0V for pulses of less than 20 ns.

## **DC and AC Operating Conditions**

	Industrial	
Operating Temperature (Ambient)	0°C - 70°C	-40°C - 85°C
V <sub>CC</sub> Power Supply	5V ± 5%	5V ± 10%

## **Compiler Mode Selection**

	PAL Mode	GAL Mode	Power-down Mode <sup>(1)</sup>
	(5828 Fuses)	(5892 Fuses)	(5893 Fuses)
Synario	ATF22V10C (DIP)	ATTF22V10C DIP (UES)	ATF22V10C DIP (PWD)
	ATF22V10C (PLCC)	ATF22C10C PLCC (UES)	ATF22V10C PLCC (PWD)
WINCUPL	P22V10	G22V10	G22V10CP
	P22V10LCC	G22V10LCC	G22V10CPLCC

Note: 1. These device types will create a JEDEC file which when programmed in ATF22V10C devices will enable the power-down mode feature. All other device types have the feature disabled.

## **DC** Characteristics

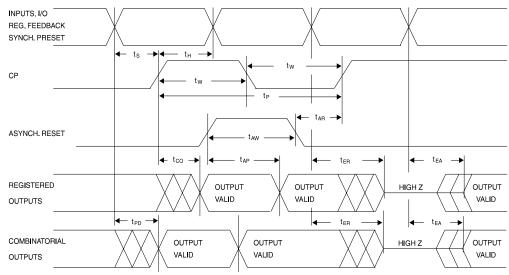
Symbol	Parameter	Condition			Min	Тур	Max	Units
I	Input or I/O Low Leakage Current	$0 \leq V_{IN} \leq V_{IL}$ (Max)				-35.0	-10.0	μA
I <sub>IH</sub>	Input or I/O High Leakage Current	$3.5 \leq V_{\text{IN}} \leq V_{\text{CC}}$	$3.5 \le V_{IN} \le V_{CC}$				10.0	μA
			C-5, 7, 10	Com.		85.0	130.0	mA
			C-10	Ind.		90.0	140.0	mA
	Power Supply Current,	$V_{\rm CC} = Max,$	C-15	Com.		65.0	90.0	mA
I <sub>CC</sub>	Standby	V <sub>IN</sub> = Max, Outputs Open	C-15	Ind.		65.0	115.0	mA
			CQ-15	Com.		35.0	55.0	mA
			CQ-15	Ind.		35.0	70.0	mA
			C-5, 7, 10	Com.			150.0	mA
Clocked Powe		ply V <sub>CC</sub> = Max, Outputs Open, f = 15 MHz	C-10	Ind.			160.0	mA
	Clocked Power Supply Current		C-15	Com.		70.0	90.0	mA
I <sub>CC2</sub>			C-15	Ind.		70.0	90.0	mA
			CQ-15	Com.		40.0	60.0	mA
			CQ-15	Ind.		40.0	80.0	mA
	Power Supply Current,	V <sub>CC</sub> = Max		Com.		10.0	100.0	μA
I <sub>PD</sub>	PD Mode	V <sub>IN</sub> = 0, Max		Ind.		10.0	100.0	μA
I <sub>OS</sub> <sup>(1)</sup>	Output Short Circuit Current	V <sub>OUT</sub> = 0.5V					-130.0	mA
V <sub>IL</sub>	Input Low Voltage				-0.5		0.8	V
V <sub>IH</sub>	Input High Voltage				2.0		V <sub>CC</sub> +0.75	V
V <sub>OL</sub>	Output Low Voltage	$V_{IN} = V_{IH} \text{ or } V_{IL},$	I <sub>OL</sub> = 16 mA	Com., Ind.			0.5	V
		V <sub>CC</sub> = Min	I <sub>OL</sub> = 12 mA	Mil.			0.5	V
V <sub>OH</sub>	Output High Voltage	$V_{IN} = V_{IH} \text{ or } V_{IL},$ $V_{CC} = Min$	I <sub>OH</sub> = -4.0 mA		2.4			V

Note: 1. Not more than one output at a time should be shorted. Duration of short circuit test should not exceed 30 sec.





## AC Waveforms <sup>(1)</sup>



Note: 1. Timing measurement reference is 1.5V. Input AC driving levels are 0.0V and 3.0V, unless otherwise specified.

## AC Characteristics<sup>(1)</sup>

		-	5	-7		-10		-15		
Symbol	Parameter	Min	Max	Min	Мах	Min	Max	Min	Max	Units
t <sub>PD</sub>	Input or Feedback to Combinatorial Output		5.0	3.0	7.5	3.0	10.0	3.0	15.0	ns
t <sub>CO</sub>	Clock to Output	1.0	4.0	2.0	4.5 <sup>(2)</sup>	2.0	6.5	2.0	8.0	ns
t <sub>CF</sub>	Clock to Feedback		2.5		2.5		2.5		2.5	ns
t <sub>S</sub>	Input or Feedback Setup Time	3.0		3.5		4.5		10.0		ns
t <sub>H</sub>	Hold Time	0		0		0		0		ns
	External Feedback 1/(t <sub>S</sub> + t <sub>CO</sub> )	142.0		125.0 <sup>(3)</sup>		90.0		55.5		MHz
f <sub>MAX</sub>	Internal Feedback 1/(t <sub>S</sub> + t <sub>CF</sub> )	166.0		142.0		117.0		80.0		MHz
	No Feedback 1/(t <sub>WH</sub> + t <sub>WL</sub> )	166.0		166.0		125.0		83.3		MHz
t <sub>w</sub>	Clock Width ( $t_{WL}$ and $t_{WH}$ )	3.0		3.0		3.0		6.0		ns
t <sub>EA</sub>	Input or I/O to Output Enable	2.0	6.0	3.0	7.5	3.0	10.0	3.0	15.0	ns
t <sub>ER</sub>	Input or I/O to Output Disable	2.0	5.0	3.0	7.5	3.0	9.0	3.0	15.0	ns
t <sub>AP</sub>	Input or I/O to Asynchronous Reset of Register	3.0	7.0	3.0	10.0	3.0	12.0	3.0	20.0	ns
t <sub>AW</sub>	Asynchronous Reset Width	5.5		7.0		8.0			15.0	ns
t <sub>AR</sub>	Asynchronous Reset Recovery Time	4.0		5.0		6.0			10.0	ns
t <sub>SP</sub>	Setup Time, Synchronous Preset	4.0		4.5		6.0			10.0	ns
t <sub>SPR</sub>	Synchronous Preset to Clock Recovery Time	4.0		5.0		8.0			10.0	ns

Notes: 1. See ordering information for valid part numbers.

2. 5.5 ns for DIP package devices.

3. 111 MHz for DIP package devices.

## Power-down AC Characteristics<sup>(1)(2)(3)</sup>

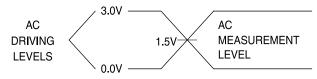
		-5		-7		-10		-15		
Symbol	Parameter	Min	Мах	Min	Max	Min	Мах	Min	Max	Units
t <sub>IVDH</sub>	Valid Input before PD High	5.0		7.5		10.0		15.0		ns
t <sub>GVDH</sub>	Valid OE before PD High	0		0		0		0		ns
t <sub>CVDH</sub>	Valid Clock before PD High	0		0		0				ns
t <sub>DHIX</sub>	Input Don't Care after PD High		5.0		7.0		10.0		15.0	ns
t <sub>DHGX</sub>	OE Don't Care after PD High		5.0		7.0		10.0		15.0	ns
t <sub>DHCX</sub>	Clock Don't Care after PD High		5.0		7.0		10.0		15.0	ns
t <sub>DLIV</sub>	PD Low to Valid Input		5.0		7.5		10.0		15.0	ns
t <sub>DLGV</sub>	PD Low to Valid OE		15.0		20.0		25.0		30.0	ns
t <sub>DLCV</sub>	PD Low to Valid Clock		15.0		20.0		25.0		30.0	ns
t <sub>DLOV</sub>	PD Low to Valid Output		20.0		25.0		30.0		35.0	ns

Notes: 1. Output data is latched and held.

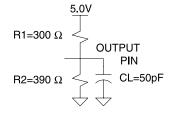
2. High-Z outputs remain high-Z.

3. Clock and input transitions are ignored.

### **Input Test Waveforms and Measurement Levels**



## **Commercial Output Test Loads**



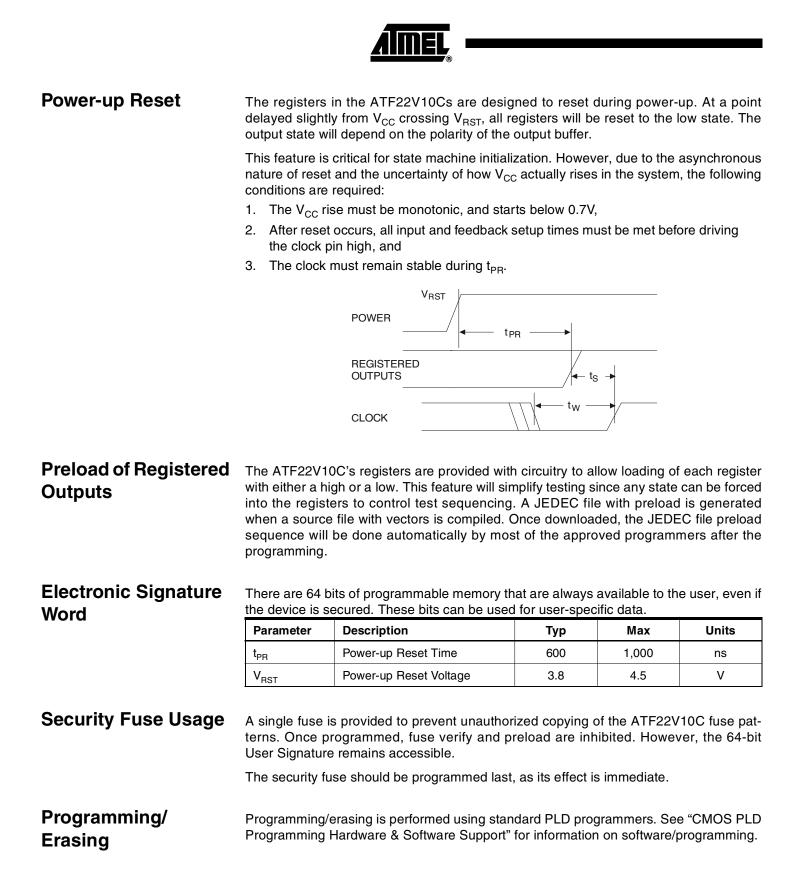
## **Pin Capacitance**

 $f = 1 \text{ MHz}, T = 25^{\circ}C^{(1)}$ 

	Тур	Max	Units	Conditions
C <sub>IN</sub>	5	8	pF	$V_{IN} = 0V$
C <sub>OUT</sub>	6	8	pF	$V_{OUT} = 0V$

Note: 1. Typical values for nominal supply voltage. This parameter is only sampled and is not 100% tested.



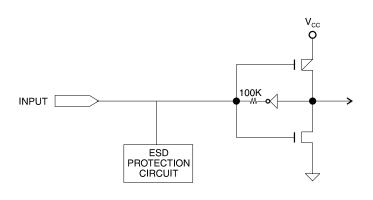


## Input and I/O Pinkeeper Circuits

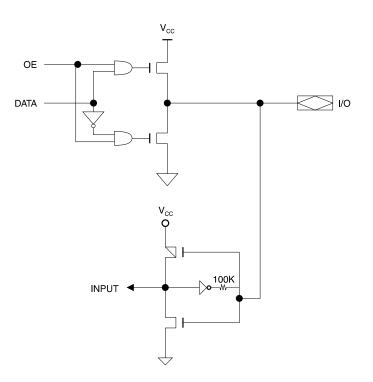
The ATF22V10C contains internal input and I/O pin-keeper circuits. These circuits allow each ATF22V10C pin to hold its previous value even when it is not being driven by an external source or by the device's output buffer. This helps to ensure that all logic array inputs are at known valid logic levels. This reduces system power by preventing pins from floating to indeterminate levels. By using pin-keeper circuits rather than pull-up resistors, there is no DC current required to hold the pins in either logic state (high or low).

These pin-keeper circuits are implemented as weak feedback inverters, as shown in the Input Diagram below. These keeper circuits can easily be overdriven by standard TTL- or CMOS-compatible drivers. The typical overdrive current required is 40  $\mu$ A.

## **Input Diagram**



I/O Diagram







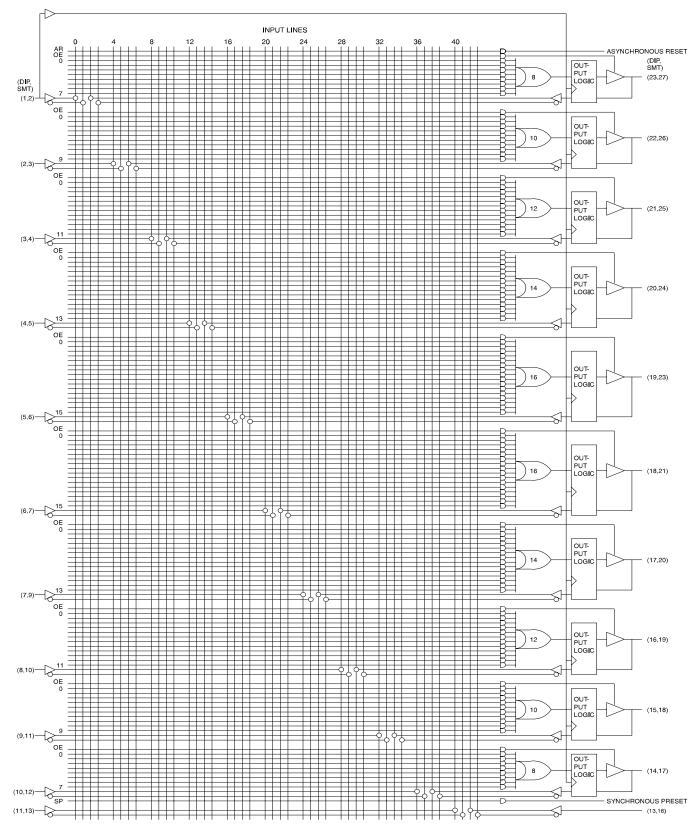
### **Power-down Mode**

The ATF22V10C includes an optional pin-controlled power-down feature. When this mode is enabled, the PD pin acts as the power-down pin (Pin 4 on the DIP/SOIC packages and Pin 5 on the PLCC package). When the PD pin is high, the device supply current is reduced to less than 100 mA. During power-down, all output data and internal logic states are latched and held. Therefore, all registered and combinatorial output data remain valid. Any outputs that were in an undetermined state at the onset of power-down will remain at the same state. During power-down, all input signals except the power-down pin are blocked. Input and I/O hold latches remain active to ensure that pins do not float to indeterminate levels, further reducing system power. The power-down pin feature is enabled in the logic design file. Designs using the power-down pin may not use the PD pin logic array input. However, all other PD pin macrocell resources may still be used, including the buried feedback and foldback product term array inputs.

PD pin configuration is controlled by the design file, and appears as a separate fuse bit in the JEDEC file. When the power-down feature is not specified in the design file, the IN/PD pin will be configured as a regular logic input.

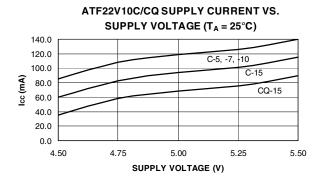
Note: Some programmers list the 22V10 JEDEC compatible 22V10C (no PD used) separately from the non-22V10 JEDEC compatible 22V10CEX (with PD used).

## Functional Logic Diagram ATF22V10C

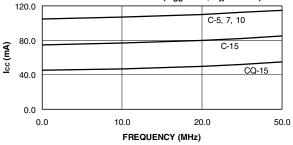




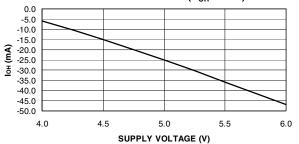




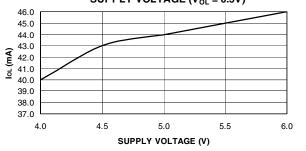
ATF22V10C/CQ SUPPLY CURRENT VS. INPUT FREQUENCY ( $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$ )

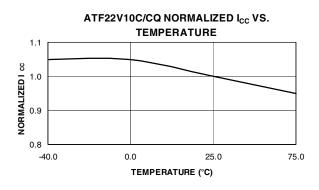


ATF22V10C/CQ OUTPUT SOURCE CURRENT VS. SUPPLY VOLTAGE ( $V_{OH} = 2.4V$ )

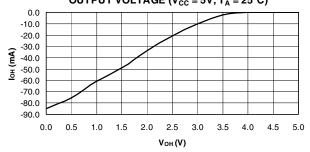


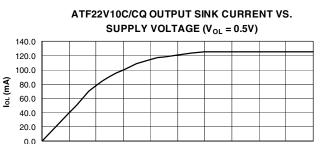






ATF22V10C/CQ OUTPUT SOURCE CURRENT VS. OUTPUT VOLTAGE ( $V_{cc} = 5V, T_A = 25^{\circ}C$ )





2.5

SUPPLY VOLTAGE (V)

3.0 3.5

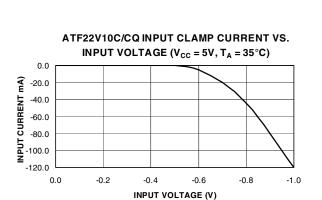
4.0 4.5

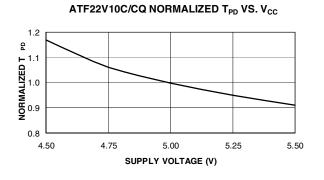
5.0

0.0

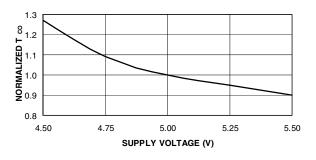
0.5 1.0

1.5 2.0

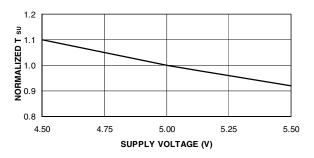


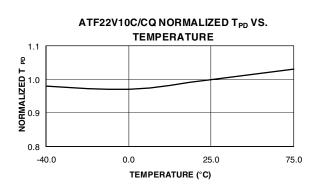


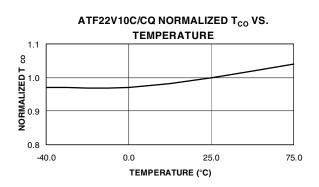
ATF22V10C/CQ NORMALIZED T<sub>co</sub> VS. V<sub>cc</sub>



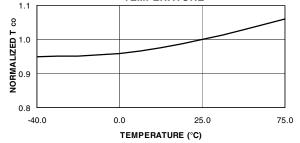
ATF22V10C/CQ NORMALIZED T<sub>SU</sub> VS. V<sub>CC</sub>



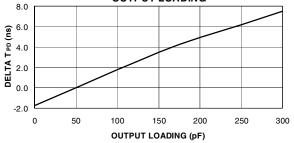


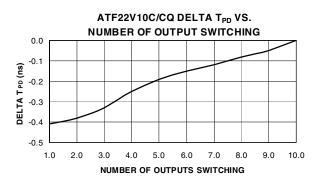


ATF22V10C/CQ NORMALIZED T<sub>SU</sub> VS. TEMPERATURE



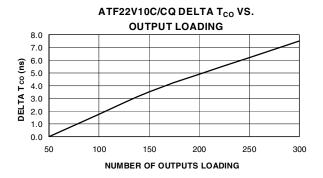
ATF22V10C/CQ DELTA T<sub>PD</sub> VS. OUTPUT LOADING

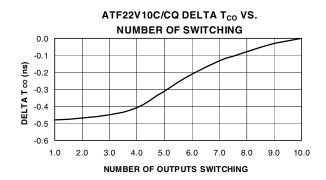












t <sub>PD</sub> (ns)	t <sub>s</sub> (ns)	t <sub>co</sub> (ns)	Ordering Code	Package	Operation Range
5	3	4	ATF22V10C-5JC	28J	Commercial
					(0°C to 70°C)
7.5	3.5	4.5	ATF22V10C-7JC	28J	Commercial
			ATF22V10C-7PC	24P3	(0°C to 70°C)
			ATF22V10C-7SC	24S	
			ATF22V10C-7XC	24X	
			ATF22V10C-7JI	28J	Industrial (-40°C to 85°C)
10	4.5	6.5	ATF22V10C-10JC	28J	Commercial
			ATF22V10C-10PC	24P3	(0°C to 70°C)
			ATF22V10C-10SC	24S	
			ATF22V10C-10XC	24X	
			ATF22V10C-10JI	28J	Industrial
			ATF22V10C-10PI	24P3	(-40°C to 85°C)
			ATF22V10C-10SI	24S	
			ATF22V10C-10XI	24X	
15	10	8	ATF22V10C-15JC	28J	Commercial
			ATF22V10C-15PC	24P3	(0°C to 70°C)
			ATF22V10C-15SC	24S	
			ATF22V10C-15XC	24X	
			ATF22V10C-15JI	28J	Industrial
			ATF22V10C-15PI	24P3	(-40°C to 85°C)
			ATF22V10C-15SI	24S	
			ATF22V10C-15XI	24X	
15	10	8	ATF22V10CQ-15JC	28J	Commercial
			ATF22V10CQ-15PC	24P3	(0°C to 70°C)
			ATF22V10CQ-15SC	24S	
			ATF22V10CQ-15XC	24X	
			ATF22V10CQ-15JI	28J	Industrial
			ATF22V10CQ-15PI	24P3	(-40°C to 85°C)
			ATF22V10CQ-15SI	24S	
			ATF22V10CQ-15XI	24X	

## ATF22V10C(Q) Ordering Information

## Using "C" Product for Industrial

To use commercial product for Industrial temperature ranges, down-grade one speed grade from the "I" to the "C" device (7 ns "C" = 10 ns "I") and de-rate power by 30%.

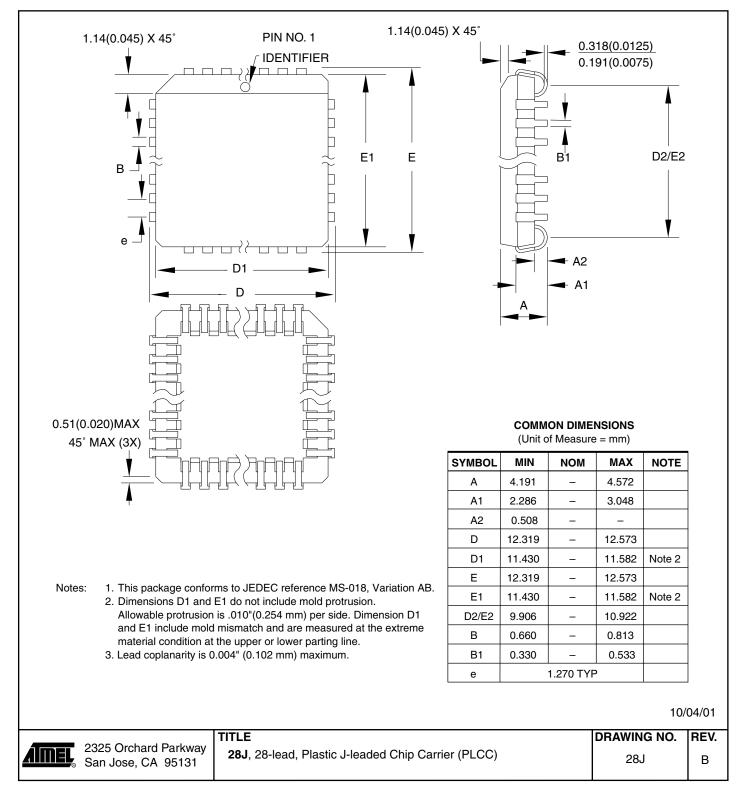
	Package Type					
28J	28-lead, Plastic J-leaded Chip Carrier (PLCC)					
24P3	24-pin, 0.300" Wide, Plastic Dual Inline Package (PDIP)					
24S	24-lead, 0.300" Wide, Plastic Gull Wing Small Outline (SOIC)					
24X	24-lead, 4.4 mm Wide, Plastic Thin Shrink Small Outline (TSSOP)					



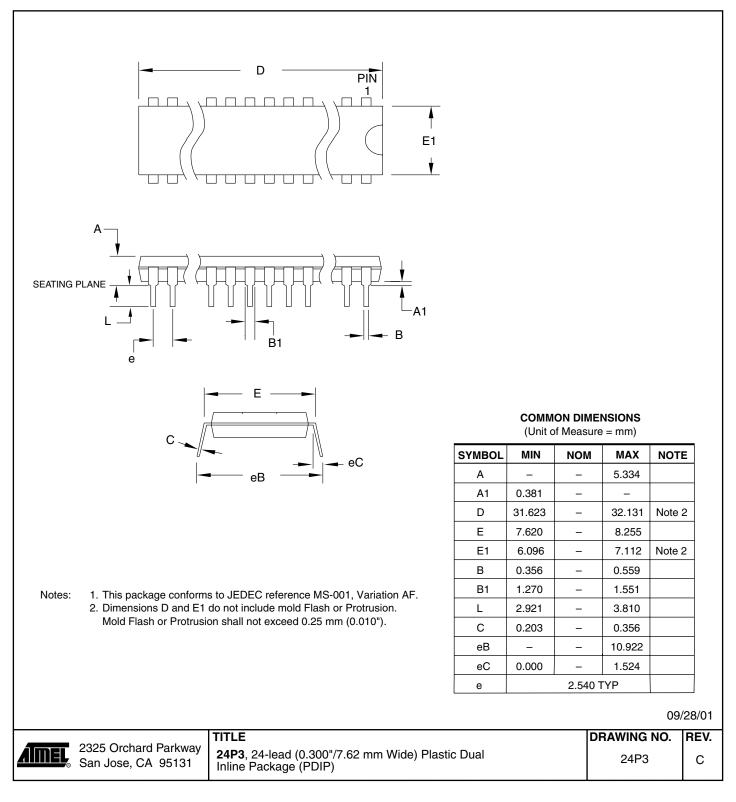


## **Packaging Information**

### 28J – PLCC

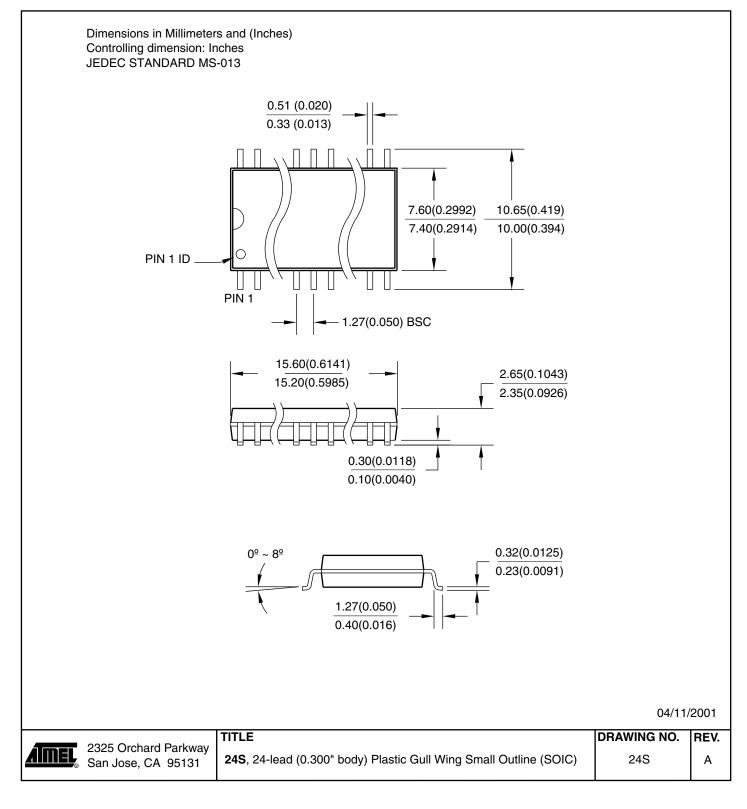


#### 24P3 – PDIP





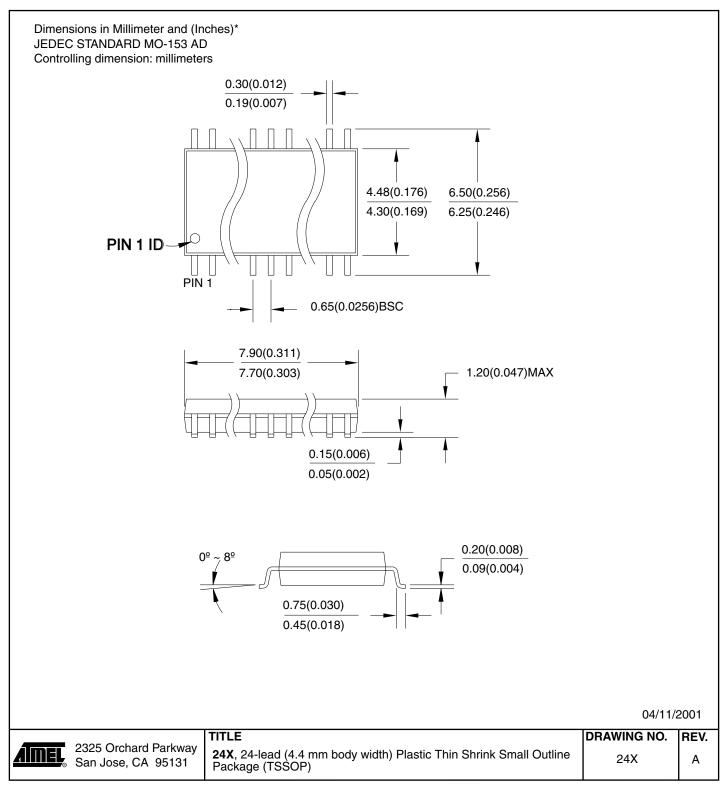






#### 24S - SOIC

#### 24X – TSSOP







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